

2SK1764

Silicon N Channel MOS FET

Application

Low frequency amplifier
High speed switching

Features

- Low on-resistance
- High speed switching
- 4 V Gate drive device can be driven from 5 V source
- Suitable for switching regulator, DC-DC converter

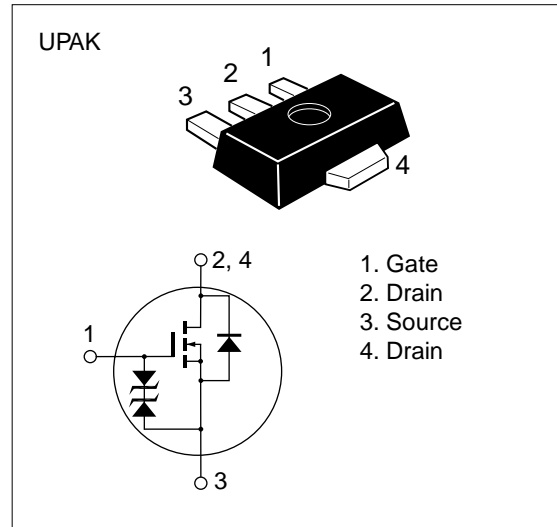


Table 1 Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Ratings | Unit |
|---------------------------|------------------|-------------|------|
| Drain to source voltage | V_{DSS} | 60 | V |
| Gate to source voltage | V_{GSS} | ±20 | V |
| Drain current | I_D | ±2 | A |
| Drain peak current | $I_{D(pulse)}^*$ | ±4 | A |
| Channel power dissipation | P_{ch}^{**} | 1 | W |
| Channel temperature | T_{ch} | 150 | °C |
| Storage temperature | T_{stg} | -55 to +150 | °C |

* $PW \leq 100 \mu s$, duty cycle $\leq 10\%$

** Value on the alumina ceramic board (12.5 x 20 x 0.7 mm)

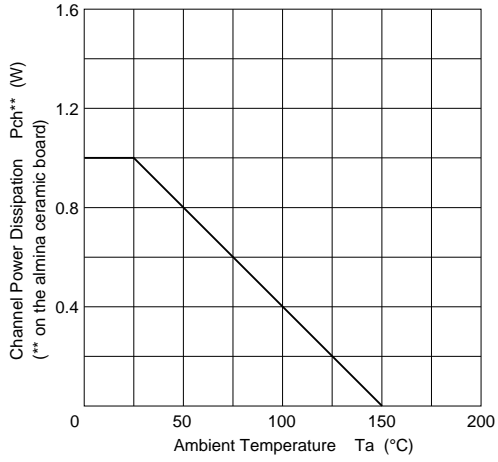
*** Marking is "KY".

Table 2 Electrical Characteristics (Ta = 25°C)

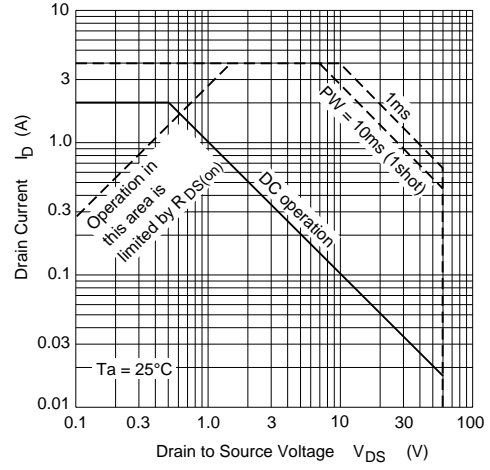
| Item | Symbol | Min | Typ | Max | Unit | Test Conditions |
|--|---------------|----------|-----|---------|---------------|--|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | 60 | — | — | V | $I_D = 10 \text{ mA}, V_{GS} = 0$ |
| Gate to source breakdown voltage | $V_{(BR)GSS}$ | ± 20 | — | — | V | $I_G = \pm 100 \text{ }\mu\text{A}, V_{DS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | 1 | — | 2 | V | $V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$ |
| Drain to source cutoff current | I_{DSS} | — | — | 10 | μA | $V_{DS} = 50 \text{ V}, V_{GS} = 0$ |
| Gate to source cutoff current | I_{GSS} | — | — | ± 5 | μA | $V_{GS} = \pm 15 \text{ V}, V_{DS} = 0$ |
| Static drain to source on state resistance | $R_{DS(on)1}$ | — | 0.3 | 0.45 | Ω | $V_{GS} = 10 \text{ V}$ $I_D = 1 \text{ A}^*$ |
| Static drain to source on state resistance | $R_{DS(on)2}$ | — | 0.4 | 0.60 | Ω | $V_{GS} = 4 \text{ V}$ $I_D = 1 \text{ A}^*$ |
| Forward transfer admittance | $ y_{fs} $ | 0.9 | 1.7 | — | S | $V_{DS} = 10 \text{ V}$ $I_D = 1 \text{ A}^*$ |
| Input capacitance | C_{iss} | — | 140 | — | pF | $V_{DS} = 10 \text{ V}$ |
| Output capacitance | C_{oss} | — | 75 | — | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | C_{rss} | — | 20 | — | pF | $f = 1 \text{ MHz}$ |
| Turn on time | t_{on} | — | 18 | — | ns | $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A}^*$ |
| Turn off time | t_{off} | — | 80 | — | ns | $R_L = 30 \text{ }\Omega$ |

* Pulse Test

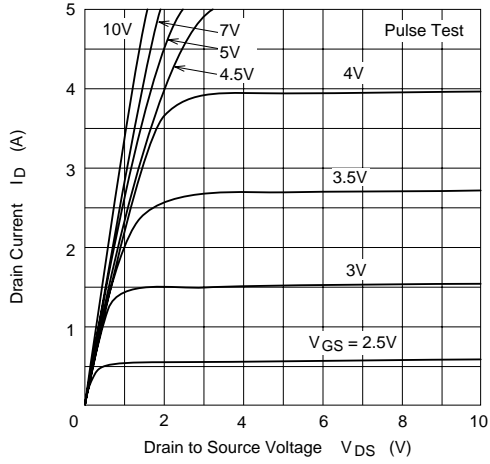
Maximum Channel Power Dissipation Curve



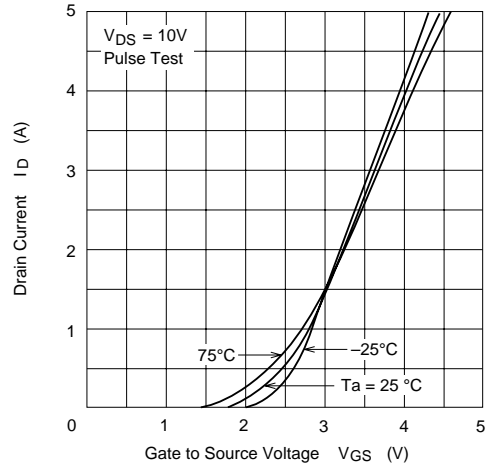
Safe Operation Area



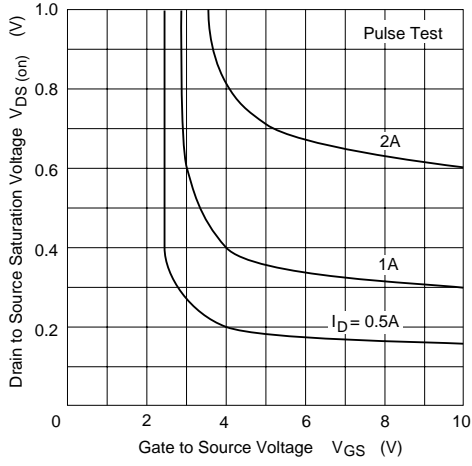
Typical Output Characteristics



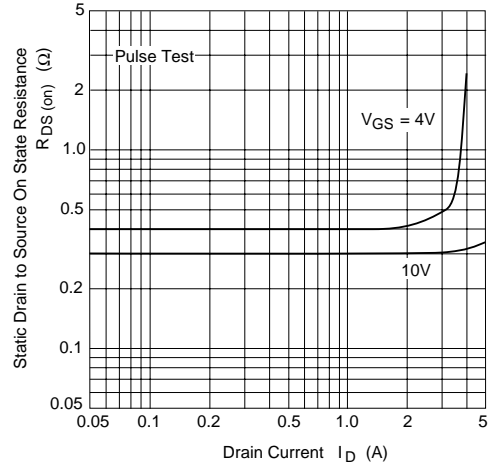
Typical Transfer Characteristics



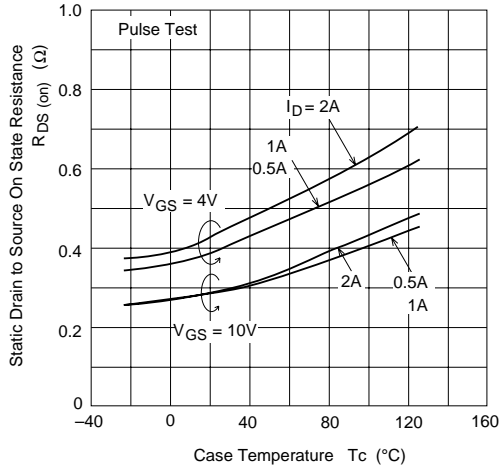
Drain to Source Saturation Voltage vs. Gate to Source Voltage



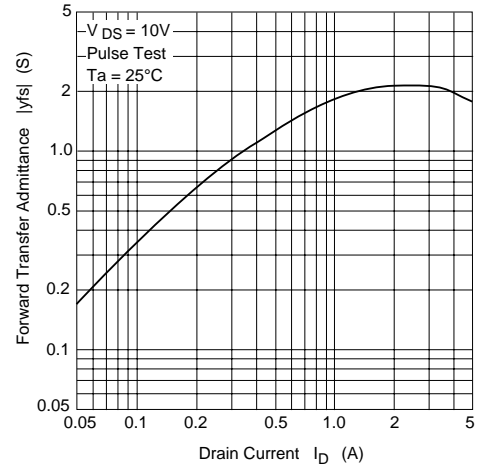
Static Drain to Source On State Resistance vs. Drain Current



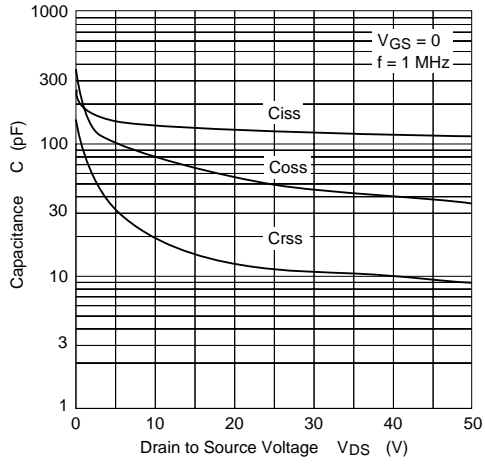
Static Drain to Source On State Resistance vs. Case Temperature



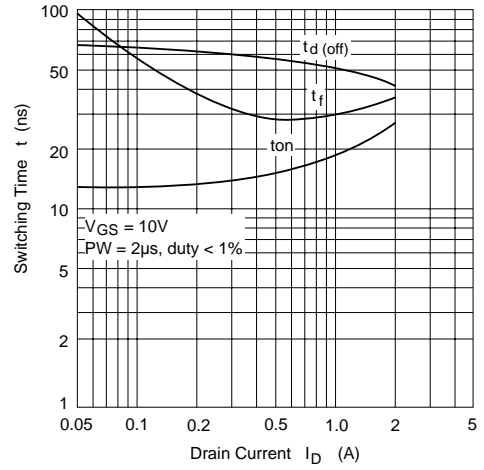
Forward Transfer Admittance vs. Drain Current



Typical Capacitance vs. Drain to Source Voltage



Switching Time vs. Drain Current



Reverse Drain Current vs. Source to Drain Voltage

